

Notice of References Cited	Application/Control No. 10/593,470		Applicant(s)/Patent Under Reexamination MIYAMOTO ET AL.	
	Examiner JOHN K. KIM		Art Unit 2834	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0048249	12-2001	Tsuboi et al.	310/12
*	B	US-6,414,300	07-2002	Mazure-Espejo et al.	250/214.1
*	C	US-5,825,104	10-1998	Kondo et al.	310/12
*	D	US-7,276,821	10-2007	Miyamoto, Yasuhiro	310/12
*	E	US-5,801,462	09-1998	Yagoto et al.	310/12
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	2002 IEEE publication, Jong et al, "Smart Silicon Sensor – Example of Hall Effect Sensors"			
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.